

# MPC5748G\_1N81M

## Mask Set Errata

Rev. 8 — 4 June 2025

Errata

## 1 Mask Set Errata for Mask 1N81M

### 1.1 Revision History

This report applies to mask 1N81M for these products:

- MPC5748G
- MPC5746G
- MPC5747G
- MPC5747C
- MPC5748C

Table 1. Mask Specific Information

jtag_id	0x0988101D
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Table 2. Revision History

Revision	Release Date	Significant Changes
8	6/2025	The following errata were added. <ul style="list-style-type: none"><li>• ERR052559</li><li>• ERR052226</li></ul>
7	8/2022	The following errata were revised. <ul style="list-style-type: none"><li>• ERR011235</li><li>• ERR010590</li></ul>
6	3/2022	The following errata were revised. <ul style="list-style-type: none"><li>• ERR050575</li></ul>
5	8/2021	The following errata were added. <ul style="list-style-type: none"><li>• ERR006308</li><li>• ERR050575</li><li>• ERR011306</li><li>• ERR010590</li><li>• ERR010542</li></ul> The following errata were revised. <ul style="list-style-type: none"><li>• ERR011235</li><li>• ERR010963</li><li>• ERR050246</li></ul>
4	3/2021	The following errata were removed. <ul style="list-style-type: none"><li>• ERR010103</li></ul> The following errata were added. <ul style="list-style-type: none"><li>• ERR011321</li><li>• ERR010385</li><li>• ERR050130</li></ul>



Table 2. Revision History...continued

Revision	Release Date	Significant Changes
		<ul style="list-style-type: none"> <li>• ERR050090</li> <li>• ERR050195</li> <li>• ERR011235</li> <li>• ERR050572</li> <li>• ERR050196</li> <li>• ERR010963</li> <li>• ERR050467</li> <li>• ERR050144</li> <li>• ERR050119</li> <li>• ERR011287</li> <li>• ERR011295</li> <li>• ERR011294</li> <li>• ERR011293</li> <li>• ERR050154</li> <li>• ERR050246</li> </ul> <p>The following errata were revised.</p> <ul style="list-style-type: none"> <li>• ERR010340</li> </ul>
3	1/2018	<p>The following errata were removed.</p> <ul style="list-style-type: none"> <li>• ERR010214</li> </ul> <p>The following errata were added.</p> <ul style="list-style-type: none"> <li>• ERR011046</li> <li>• ERR010723</li> <li>• ERR010396</li> <li>• ERR011096</li> <li>• ERR010603</li> <li>• ERR010789</li> <li>• ERR011150</li> <li>• ERR010215</li> <li>• ERR009322</li> <li>• ERR010620</li> <li>• ERR009135</li> <li>• ERR010452</li> <li>• ERR010595</li> <li>• ERR009028</li> <li>• ERR010609</li> <li>• ERR010340</li> <li>• ERR010594</li> <li>• ERR008804</li> <li>• ERR010413</li> </ul> <p>The following errata were revised.</p> <ul style="list-style-type: none"> <li>• ERR010143</li> </ul>
2 June 2016	7/2016	<p>The following errata were removed.</p> <ul style="list-style-type: none"> <li>• ERR008179</li> </ul> <p>The following errata were added.</p> <ul style="list-style-type: none"> <li>• ERR010103</li> <li>• ERR010118</li> <li>• ERR010143</li> <li>• ERR009978</li> <li>• ERR009996</li> </ul>

Table 2. Revision History...continued

Revision	Release Date	Significant Changes
		<ul style="list-style-type: none"> <li>• ERR010132</li> <li>• ERR010362</li> <li>• ERR010368</li> <li>• ERR009873</li> <li>• ERR010323</li> <li>• ERR009995</li> <li>• ERR010361</li> <li>• ERR010214</li> <li>• ERR010440</li> <li>• ERR010141</li> </ul> <p>The following errata were revised.</p> <ul style="list-style-type: none"> <li>• ERR009200</li> <li>• ERR008933</li> </ul>
1	5/2015	Initial Revision

## 1.2 Errata and Information Summary

Table 3. Errata and Information Summary

Erratum ID	Erratum Title
<a href="#">ERR006308</a>	USB: Host non-doubleword –aligned buffer address can cause host to hang on OUT Retry
<a href="#">ERR007885</a>	ENET: Potential sequencing issue with TDAR in Multi-Queue mode
<a href="#">ERR007991</a>	FLASH: Rapid Program or Erase Suspend fail status
<a href="#">ERR008042</a>	FCCU: EOUT signals are active, even when error out signaling is disabled
<a href="#">ERR008080</a>	LINFlexD: TX pin gets set to High-Z when in IDLE state
<a href="#">ERR008180</a>	HSM: e200z0 Nexus interface DQTAG implemented as variable length field in DQM message
<a href="#">ERR008406</a>	SMPU: Process Identifier region hit determination is not available in debug mode
<a href="#">ERR008714</a>	ADC: Conversions on an open channel with the presampling feature enabled do not return the expected results
<a href="#">ERR008759</a>	FlexCAN: FD frame format not compliant to the new ISO/CD 11898-1: 2014-12-11
<a href="#">ERR008770</a>	FlexRAY: Missing TX frames on Channel B when in dual channel mode and Channel A is disabled
<a href="#">ERR008804</a>	ADC: Setting the DMA request to be cleared on read of data registers does not work
<a href="#">ERR008868</a>	WKPU: Wakeup Pads pull-ups cannot be enabled in Standby Mode
<a href="#">ERR008870</a>	NEXUS: Mutli core tracing using NEXUS3 gives corrupted traces for the case when the cores are in the ratio of 2:1
<a href="#">ERR008871</a>	ME: In STANDBY/LPU STANDBY modes, if FIRC is disabled all 256kB of STANDBY RAM is retained
<a href="#">ERR008880</a>	MEMU: After exit from LPU RUN mode, the MEMU_PROT registers are uninitialized which may impact the usage of MEMU
<a href="#">ERR008883</a>	HSM: Input Output Control enables pad and alternative pad
<a href="#">ERR008898</a>	ME: For a supply voltage of greater than 5.3V the MCU may be reset during a LPU_STANDBY to LPU_RUN mode transition

Table 3. Errata and Information Summary...continued

Erratum ID	Erratum Title
<a href="#">ERR008901</a>	Flash: Flash internal regulation mode may lead to power-on-reset when in STANDBY and LPU modes
<a href="#">ERR008902</a>	STM: The STM Counter Register will not report count value when TEN is cleared
<a href="#">ERR008933</a>	LINFlexD: Inconsistent sync field may cause an incorrect baud rate and the Sync Field Error Flag may not be set
<a href="#">ERR008938</a>	LINFlexD: Corruption of Tx data in LIN mode with DMA feature enabled (applicable to LIN1)
<a href="#">ERR008939</a>	LINFlexD: Tx through DMA can be re-triggered after abort in LIN/UART modes or can prematurely end on the event of bit error with LINCR2[IOBE] bit being set in LIN mode (applicable only for LIN1)
<a href="#">ERR009028</a>	C55FMC: Possibility of a false Address Encode Error during flash read-while-write operation
<a href="#">ERR009076</a>	FCCU: Fault Collection and Control Unit glitch filter behavior is indeterministic
<a href="#">ERR009135</a>	NPC: LPM Debug handshake does not work for STOP Mode using all TCK frequencies
<a href="#">ERR009200</a>	MC_ME and LPU: JTAG TCK pin must be configured to ensure successful exit from STANDBY and LPU modes
<a href="#">ERR009321</a>	ADC: Conversions may fail if Pre-Sampling is enabled
<a href="#">ERR009322</a>	TDM: Erase of TDR flash block may be blocked by the TDM
<a href="#">ERR009328</a>	ENET: Not possible to set the entire range of the ENET Timer Compare Capture Register (ENET_TCCR0[TCC] and ENET_TCCR1[TCC])
<a href="#">ERR009335</a>	IAHB: Default programming of Intelligent AHB Gasket pending read optimisation can lead to masters stalling or receiving incorrect or spurious data
<a href="#">ERR009873</a>	PFLASH: Calibration remap to flash memory not supported on 16KB and 32KB flash blocks in address range 0x00F90000-0x00FBFFFF
<a href="#">ERR009978</a>	eMIOS: Unexpected channel flag assertion during GPIO to MCB mode transition
<a href="#">ERR009995</a>	DSPI0 and DSPI1: Frame transfer does not restart in case of DSI parity error in master mode
<a href="#">ERR009996</a>	DSPI0 and DSPI1: Frame transfer does not restart after DSI frame matches preprogrammed value
<a href="#">ERR010118</a>	HSM: TRNG can only select FIRC for clock source
<a href="#">ERR010132</a>	LPU: Mode transition to LPU_STOP or LPU_STANDBY may not complete
<a href="#">ERR010141</a>	LPU: LPU_RUN mode system clock must be preconfigured for undivided FIRC prior to LPU_STANDBY entry
<a href="#">ERR010143</a>	CMP_0: At exit from STANDBY the output of Comparator 0 is configured to high-impedance
<a href="#">ERR010215</a>	DSPI0/1 and SPI0/3 : Frame transfer does not restart in case of SPI parity error in master mode
<a href="#">ERR010323</a>	MC_ME: The transition from DRUN/RUN mode to STANDBY will not complete if a wake-up is triggered in a 50nS window.
<a href="#">ERR010340</a>	NZxC3: ICNT and HIST fields of a Nexus message are not properly reset following a device reset
<a href="#">ERR010361</a>	MC_ME & LPU: The transition between DRUN/RUN mode to STANDBY or DRUN/RUN mode to LPU_RUN may not complete if EXR is asserted.
<a href="#">ERR010362</a>	MC_ME & LPU: The transition between DRUN/RUN mode to STANDBY or DRUN/RUN mode to LPU_RUN may not complete if any LVD is asserted or PORST goes low

Table 3. Errata and Information Summary...continued

Erratum ID	Erratum Title
<a href="#">ERR010368</a>	FlexCAN: Transition of the CAN FD operation enable bit may lead FlexCAN logic to an inconsistent state.
<a href="#">ERR010385</a>	e200z4: Incorrect branch displacement at 16K memory boundaries
<a href="#">ERR010396</a>	PASS: Password challenge to PASS fails while program erase ongoing in any block in memory partition 0
<a href="#">ERR010413</a>	HSM: HSM RAM initialization clock out of specification when Accelerated Low Power Exit is enabled with FMPLL = 160MHz
<a href="#">ERR010440</a>	MC_ME & LPU: The transition between DRUN/RUN mode to STANDBY or DRUN/RUN mode to LPU_RUN may not complete if a reset is asserted.
<a href="#">ERR010452</a>	eDMA: When master ID replication is enabled, the stored ID and privilege level will change if read by another master.
<a href="#">ERR010542</a>	DSPI: Transmit, Command, and Receive FIFO fill flags in status register is not cleared when DMA is improperly configured
<a href="#">ERR010590</a>	PLL: Might remain unlocked when enabled after Standby or power on
<a href="#">ERR010594</a>	ENET: The ENET1 (Ethernet) module does not function unless the Peripheral control register (MC_ME_PCTL6) is enabled .
<a href="#">ERR010595</a>	FlexCAN: FLEXCAN1-7 modules will not work unless the Fast External Oscillator (FXOSC) clock source is enabled
<a href="#">ERR010603</a>	NPC: Nexus Port Controller (NPC) must be enabled to allow mode changes during debug
<a href="#">ERR010609</a>	MC_CGM: CLKOUT_0 and CLKOUT_1 may stop if the clock selection is changed when configured for divide by 2
<a href="#">ERR010620</a>	FlexRay: The FS80 clock source should not be selected for the FlexRay protocol clock when the MCU clocking is configured for Linear Dynamic Frequency Scaling
<a href="#">ERR010723</a>	NPC: Repeated Nexus3 Debug Status messages can be observed if more than one master (including a device core) is active and the core is subsequently disabled
<a href="#">ERR010789</a>	PFLASH: EEPROM ECC error suppression is not supported on 16KB and 32KB flash blocks in the address range 0x00F90000-0x00FBFFFF
<a href="#">ERR010963</a>	Flash: Memory accesses may be corrupted when flash is operating between 33MHz and 75MHz
<a href="#">ERR011046</a>	ENET: The timer mode ENETx_TCSRn[TMODE] settings 1010 and 1001 are unusable
<a href="#">ERR011096</a>	SAI: Internal bit clock is not generated when RCR2[BCI]=1 or TCR2[BCI]=1
<a href="#">ERR011150</a>	SAI: Internally generated receive or transmit BCLK cannot be re-enabled if it is first disabled when RCR2[DIV] or TCR2[DIV] > 0
<a href="#">ERR011235</a>	EMIOS: Any Unified Channel running in OPWMB or OPWMCB mode may function improperly if the source counter bus is generated by Unified channel in MC mode
<a href="#">ERR011287</a>	CMU: Sudden loss of clock does not signal the Fault Collection and Control Unit
<a href="#">ERR011293</a>	EMIOS: For any UC operating in OPWFMB mode the Channel Count register should not be written with a value greater than Channel B Data register value
<a href="#">ERR011294</a>	EMIOS: OPWFMB and MCB mode counter rollover resets the counter to 0x0 instead of 0x1 as mentioned in the specification
<a href="#">ERR011295</a>	EMIOS: In OPWFMB mode, A1/B1 registers do not get reloaded with A2/B2 register values if counter value returns 0x1 after counter wrap condition

Table 3. Errata and Information Summary...continued

Erratum ID	Erratum Title
<a href="#">ERR011306</a>	SAR ADC: Incorrect value of ADC power down exit delay evaluated by the formula given in PDEDR [PDED] field description
<a href="#">ERR011321</a>	PIT_RTI: Generates false RTI interrupt on re-enabling
<a href="#">ERR050090</a>	DSPI/SPI: Incorrect data may be transmitted in slave mode
<a href="#">ERR050119</a>	FlexRay: Disabling of FlexRay Message Buffer during the STARTUP Protocol State takes longer than expected three Slots
<a href="#">ERR050130</a>	PIT: Temporary incorrect value reported in LMTR64H register in lifetimer mode
<a href="#">ERR050144</a>	SAI: Setting FCONT=1 when TMR>0 may not function correctly
<a href="#">ERR050154</a>	Clocking: Device operation is impacted with a particular MC_CGM system divider configuration.
<a href="#">ERR050195</a>	MEMU_0: MEMU_0 operation is impacted with a particular MC_CGM system divider configuration.
<a href="#">ERR050196</a>	STANDBY EXIT: Device may not come out of reset if a short functional reset comes immediately after wakeup event.
<a href="#">ERR050246</a>	FlexCAN: Receive Message Buffers may have its Code Field corrupted if the Receive FIFO function is used
<a href="#">ERR050467</a>	PLL: Possible loss of lock when using the PLL bypass calibration mode
<a href="#">ERR050572</a>	SIRC: Clock output may contain extra clock pulses
<a href="#">ERR050575</a>	eMIOS: Any Unified Channel running in OPWMCB mode may function improperly if the lead or trail dead time insertion features is used and its timebase is generated by Unified channel in MCB mode
<a href="#">ERR052226</a>	SWT: Toggling watchdog enable may cause unexpected timeout in some boundary conditions
<a href="#">ERR052559</a>	INTC: Register updated on bus error

## 2 Known Errata

### ERR006308: USB: Host non-doubleword –aligned buffer address can cause host to hang on OUT Retry

#### Description

The USB host core operating in streaming mode may underrun while sending the data packet of an OUT transaction. The host then retries the OUT transaction according to the USB specification.

This issue occurs during the OUT retry. The USB host may hang on OUT retry if the data buffer start address is not 4-byte aligned. This applies to both the host controller and the OTG controller in host mode.

#### Workaround

- Set the host TXFIFO threshold to a large value (TXFIFOTHRES in the TXFILLTUNING register). This increases the tolerance to bus latency and avoids a FIFO underrun.
- Set the Stream Disable bit (SDIS) to 1 in the USBMODE register. This forces the controller to load an entire packet in the FIFO before starting to transmit on the USB bus. Hence, the FIFO never underruns. This

somewhat reduces the maximum bandwidth of the USB, because there is idle time when the the controller waits for the entire packet to be loaded.

## ERR007885: ENET: Potential sequencing issue with TDAR in Multi-Queue mode

### Description

When the 10/100-Mbps Ethernet Media Access Control (ENET MAC) module is in Multi-queue mode, there is a potential sequencing issue between the module clearing the ENET Transmit Descriptor Active Register (ENET\_TDARn\_TDAR) bit and the software setting it. This can cause the module to hang.

### Workaround

ENET\_TDARn\_TDAR should be set by software after it is cleared by the ENET. This is achieved by introducing a short delay after a new Transmit Buffer Descriptor (TxBD) is prepared and written into a designated memory.

- Software prepares a new TxBD and stores/writes it into a designated memory
- Software introduces a delay by reading the relevant ENET\_TDARn\_TDAR 4 times as shown by the following pseudo-code :

```
For (i=0; i<4; i++) // 4 Reads should be sufficient
```

```
{  
//Read TDAR  
If (TDAR == 0)  
{  
tdar_trigger = 1  
exit_for_loop  
}  
else  
tdar_trigger = 0  
end  
}  
If (tdar_trigger)  
Set TDAR = 1 (i.e., set ENET_TDARn_TDAR to 1)  
Else  
Do_nothing (i.e., don't trigger TDAR)  
End
```

Therefore the software can set the TDAR bit as soon as it is detected as zero.

**ERR007991: FLASH: Rapid Program or Erase Suspend fail status****Description**

If a flash suspend operation occurs during a 5us window during a verify operation being executed by the internal flash program and erase state machine, and the suspend rate continues at a consistent 20us rate after that, it is possible that the flash will not exit the program or erase operation. A single suspend during a single program or erase event will not cause this issue to occur.

Per the flash specification, a flash program or erase operation should not be suspended more than once every 20 us, therefore, if this requirement is met, no issue will be seen. IF the suspend rate is faster than 20 us continuously, a failure to program/erase could occur.

**Workaround**

When doing repeated suspends during program or erase ensure that suspend period is greater than 20us.

**ERR008042: FCCU: EOUT signals are active, even when error out signaling is disabled****Description**

Every time the Fault Collection and Control Unit (FCCU) moves into fault state caused by an input fault for which the error out reaction is disabled ( $FCCU\_EOUT\_SIG\_ENn[EOUTENx]=0$ ), the Error Out 1 and 2 (EOUT[0] and EOUT[1]) will become active for a duration of 250 us plus the value programmed into the FCCU Delta Time register ( $FCCU\_DELTA\_T[DELTA\_T]$ ). EOUT is not affected if the FCCU moves into the alarm state that generates an interrupt (IRQ), if the Fault is cleared before the alarm timeout.

This erratum does not affect the outputs of other pins (for example, for communication modules like CAN/Flexray). Only the EOUT signal is impacted.

**Workaround**

There are three possible workarounds:

- 1) Enable EOUT signaling for all enabled error sources.
- 2) In case external device (which evaluates EOUT) can communicate with the MCU, the following procedure could be used:
  - a) Program any duration of EOUT as per application needs ( $FCCU\_DELTA\_T[DELTA\_T]$ )
  - b) For faults requiring error out reaction, the software shall validate EOUT via separate communication channel (like I2C) while EOUT is asserted.
  - c) External device shall implement a timeout mechanism to monitor EOUT validation by separate channel.
  - d) Following scenarios shall be considered as valid EOUT reactions:
    - d1) Validation is performed while EOUT is asserted
    - d2) Timeout occurs but no validation and EOUT is still asserted.
- 3) In case external device (which evaluates EOUT) cannot communicate with the MCU, following procedure could be used:
  - a) Program the error out duration to a duration x ( $FCCU\_DELTA\_T[DELTA\_T]$ ).
  - b) For faults requiring error out reaction, clear the fault after the pin has continued to be asserted for a longer duration (for example  $2 \cdot \text{duration } x$ ). This will artificially create a long pulse on EOUT.

- c) For faults which do not require error out reaction, clear the fault within duration x. This will artificially create a short pulse on EOUT.
- d) External device should ignore short pulse of duration x while recognizing longer pulses as valid reaction.
- e) While clearing the fault, the associated software shall check the pending faults.

### **ERR008080: LINFlexD: TX pin gets set to High-Z when in IDLE state**

#### **Description**

LINFlex drives the buffer enable signal for its transmit pin output (TX) to be '0' after transmitting the LIN frame. This causes the TX line to go to High-Z which will be an issue if the associated LIN transceiver has an internal "pull down".

Issue will also occur when module is configured in UART mode with the TX output pin becoming High-Z when idle.

#### **Workaround**

When operating in LIN mode, use a LIN transceiver with internal "pull up". If the transceiver has an internal "pull down", add an external "pull up".

When operating in UART mode, the issue can be worked around by enabling the internal pull up on the TX pin using the corresponding SIU\_MSCR register.

### **ERR008180: HSM: e200z0 Nexus interface DQTAG implemented as variable length field in DQM message**

#### **Description**

The Hardware Security Module (HSM) core (e200z0) implements the Data Tag (DQTAG) field of the Nexus Data Acquisition Message (DQM) as a variable length packet instead of an 8-bit fixed length packet. This may result in an extra clock ("beat") in the DQM trace message depending on the Nexus port width selected for the device.

#### **Workaround**

Tools should decode the DQTAG field as a variable length packet instead of a fixed length packet.

### **ERR008406: SMPU: Process Identifier region hit determination is not available in debug mode**

#### **Description**

The Process Identifier (PID) feature can be used in the determination of whether the current access hits the SMPU region descriptor. When in debug mode the PID feature is not functional.

#### **Workaround**

The SMPU PID feature should be used when debug mode is disabled.

## ERR008714: ADC: Conversions on an open channel with the presampling feature enabled do not return the expected results

### Description

The analog-to-digital converter (ADC) presampling feature will precharge an ADC channel sample capacitor to an internal voltage. The internal voltage is selected by the Internal Voltage Selection for Presampling bit field (PREVAL0) of the ADC's Presampling Control Register (ADC\_PSCR). The user has either the option of sampling an ADC reference voltage rail (VDD) or a ground (VSS). If the convert presampled value bit (PRECONV) of the ADC\_PSCR register is cleared (ADC\_PSCR[PRECONV]=0b0) then the presampling stage is followed by the sampling of the ADC channel input and then the conversion is performed. If the user has selected VSS as the internal sample voltage when this is done on an open or unconnected channel, the conversion result will be closer to 1000 when it is expected to be 0. If the user has selected VDD as the internal voltage the conversion result will be closer to 2000 rather than 4095. If ADC\_PSCR[PRECONV]=0b1 then sampling of the ADC channel input is bypassed and the presampled voltage is converted directly. This conversion result is close to the expected value for the presampled voltage.

### Workaround

Do not expect conversion result to be close to zero or full-scale on an open channel with presampling enabled and ADC\_PSCR[PRECONV] = 0b0.

## ERR008759: FlexCAN: FD frame format not compliant to the new ISO/CD 11898-1: 2014-12-11

### Description

This version of the device implements a Flexible Controller Area Network (FlexCAN) module version that implements a Flexible Data (CAN-FD) frame format according to ISO/WD 11898-1: 2013-12-13. However, it is not compliant with the new ISO/CD 11898-1: 2014-12-11 format. The frame format was updated during the ISO standardization process.

The limitations are the following:

- the FD frame format is incompatible, the Cyclic Redundancy Check [CRC] does not include the added stuff bit count field
- the FD CRC computation is incompatible, a different seed value is used.

As a consequence this device is not suitable for use in CAN-FD networks that use the new FD frame format according to ISO/CD 11898-1: 2014-12-11.

FlexCAN3 with CAN FD feature enabled is affected by this defect.

### Workaround

Use CAN-FD mode in networks that only includes devices that conform to the ISO/WD 11898-1: 2013-12-13 frame format.

The Classic CAN mode is unaffected and can be used without restrictions.

**ERR008770: FlexRAY: Missing TX frames on Channel B when in dual channel mode and Channel A is disabled****Description**

If the FlexRay module is configured in Dual Channel mode, by clearing the Single Channel Device Mode bit (SCM) of the Module Control register (FR\_MCR[SCM]=0), and Channel A is disabled, by clearing the Channel A Enable bit (FR\_MCR[CHA]=0) and Channel B is enabled, by setting the Channel B enable bit (FR\_MCR[CHB]=1), there will be a missing transmit (TX) frame in adjacent minislots (even/odd combinations in Dynamic Segment) on Channel B for certain communication cycles. Which channel handles the Dynamic Segment or Static Segment TX message buffers (MBs) is controlled by the Channel Assignment bits (CHA, CHB) of the Message Buffer Cycle Counter Filter Register (FR\_MBCCFRn). The internal Static Segment boundary indicator actually only uses the Channel A slot counter to identify the Static Segment boundary even if the module configures the Static Segment to Channel B (FR\_MBCCFRn[CHA]=0 and FR\_MBCCFRn[CHB]=1). This results in the Buffer Control Unit waiting for a corresponding data acknowledge signal for minislot:N in the Dynamic Segment and misses the required TX frame transmission within the immediate next minislot:N+1.

**Workaround**

1. Configure the FlexRay module in Single Channel mode (FR\_MCR[SCM]=1) and enable Channel B (FR\_MCR[CHB]=1) and disable Channel A (FR\_MCR[CHA]=0). In this mode the internal Channel A behaves as FlexRay Channel B. Note that in this mode only the internal channel A and the FlexRay Port A is used. So externally you must connect to FlexRay Port A.
2. Enable both Channel A and Channel B when in Dual Channel mode (FR\_MCR[CHA]=1] and FR\_MCR[CHB]=1). This will allow all configured TX frames to be transmitted correctly on Channel B.

**ERR008804: ADC: Setting the DMA request to be cleared on read of data registers does not work****Description**

The Successive Approximation Register (SAR) Analog-to-Digital Converter (ADC) can generate DMA requests to the DMA controller. If the DMA Clear sequence enable bit in the ADC DMA Enable register (ADC\_DMAE[DCLR]) is set to 0b1 the DMA request should be cleared upon a read of the data registers but it is cleared automatically without a read.

**Workaround**

Do not use the ADC module with the DMA request cleared on read of data registers enabled, ADC\_DMAE[DCLR]=0b1. Instead configure ADC\_DMAE[DCLR]=0b0. With DMA enabled, the request will only be cleared once the DMA controller acknowledges it and accesses the conversion data register.

**ERR008868: WKPU: Wakeup Pads pull-ups cannot be enabled in Standby Mode****Description**

During Standby Mode, all 30 external wakeup Pins cannot be configured in Pulled-Up state using WKPU register WIPUER.

If WIPUER[x] is programmed to value 0, the wakeup pins go to a High-Z state.

If WIPUER[x] is programmed to value 1, the wakeup pins gets configured to Pulled-down state.

In All Modes except Standby Mode, the pull state of wakeup Pins can be configured using its associated SIUL\_MSCRx[PUE] and SIUL\_MSCRx[PUS] register bits.

### Workaround

Use external pull up on board if wakeup pins are required to be pulled up in standby mode.

## **ERR008870: NEXUS: Mutli core tracing using NEXUS3 gives corrupted traces for the case when the cores are in the ratio of 2:1**

### Description

Mutli core tracing using NEXUS3 gives corrupted traces for the case when the cores are in the ratio of 2:1

This is applicable to both data and instruction trace.

There is no issue when multi core tracing only Z4A and Z4B as the frequency ratio is always 1:1.

Care has to be taken when multi core tracing of Z4A/Z4B and Z2 as the default frequency ratio is 2:1.

### Workaround

There are two workarounds:

1. Enable timestamping during tracing.
2. Configure the Clock Generation Module (CGM) such that the Z4A/Z4B and Z2 core frequency ratio is 1:1.

## **ERR008871: ME: In STANDBY/LPU STANDBY modes, if FIRC is disabled all 256kB of STANDBY RAM is retained**

### Description

For the case when the FIRC is enabled in STANDBY/LPU STANDBY mode the amount of RAM retained in STANDBY mode is configurable at the PMCDIG RAM Domain Configuration Register (PMCDIG\_RDCR). However, for the case when the FIRC is disabled in STANDBY mode the configuration at PMCDIG\_RDCR is not applied and all 256K RAM is retained in STANDBY mode.

### Workaround

When the FIRC is disabled in STANDBY/LPU STANDBY mode the user need not select the amount of RAM to be retained in STANDBY mode, controlled at PMCDIG\_RDCR.

## **ERR008880: MEMU: After exit from LPU RUN mode, the MEMU\_PROT registers are uninitialized which may impact the usage of MEMU**

### Description

The MEMU\_PROT module corresponds to the register protection unit for MEMU.

Both MEMU and MEMU\_PROT are present in power domain2.

The issue is that the MEMU PROT module does not get initialized after LPU RUN to DRUN mode transition.

This will lead to random register values in MEMU PROT including the LOCK bits which will hinder the usage of MEMU by preventing the user from re-writing MEMU registers.

### Workaround

If the Lock bits get set, the only workaround is to issue a Reset. This could be done using soft reset from the user application code.

## ERR008883: HSM: Input Output Control enables pad and alternative pad

### Description

There is no way to select between the 2 ports available for each of the functions HSM\_DO0 and HSM\_DO1  
HSM\_IOCTL[DO\_EN0] will enable output on PD[12] and PI[6]  
HSM\_IOCTL[DO\_EN1] will enable output on PB[12] and PI[7]

### Workaround

When enabling the HSM IO function the user must consider that each HSM output will require the allocation of 2 ports.

## ERR008898: ME: For a supply voltage of greater than 5.3V the MCU may be reset during a LPU\_STANDBY to LPU\_RUN mode transition

### Description

The MPC5748G datasheet specifies a maximum supply voltage (VDD\_HV\_A) of 5.5V when the MCU is configured for the 5.0V range. For a supply voltage of 5.3V and greater there is a possibility the MCU may trigger a power-on-reset at the LPU\_STANDBY to LPU\_RUN mode transition. Note the following STANDBY mode transitions are not affected

- STANDBY to DRUN
- LPU\_STANDBY to DRUN

This issue is only present in a corner case of the silicon process.

### Workaround

When the supply voltage is 5.3V and greater the user should exit LPU\_STANDBY via DRUN and then re-enter LPU\_RUN.

## ERR008901: Flash: Flash internal regulation mode may lead to power-on-reset when in STANDBY and LPU modes

### Description

For the case when a long functional reset or destructive reset is asserted in STANDBY and LPU modes this may lead to a POR (power-on-reset). This issue is only observed when the flash is configured for internal regulation mode. When the flash is supplied externally this issue is not observed.

## Workaround

In the event of a reset the application software has to restart so the POR should not add to this overhead.

### **ERR008902: STM: The STM Counter Register will not report count value when TEN is cleared**

#### Description

For the case when the System Timer Module (STM) counter moves from the running state to the disabled state using the Timer Counter Enable (STM\_CR[TEN]) the STM Count Register (STM\_CNT) will report zero or the last counter load value, instead of the counter value. Note that when TEN is reasserted the counter will continue from the last count value.

#### Workaround

To read the current value of the STM Count Register, TEN must be enabled.

### **ERR008933: LINFlexD: Inconsistent sync field may cause an incorrect baud rate and the Sync Field Error Flag may not be set**

#### Description

When the LINFlexD module is configured as follows:

1. LIN (Local Interconnect Network) slave mode is enabled by clearing the Master Mode Enable bit in the LIN Control Register 1 (LINC1[MME] = 0b0)
2. Auto synchronization is enabled by setting LIN Auto Synchronization Enable (LINC1[LASE] = 0b1)

The LINFlexD module may automatically synchronize to an incorrect baud rate without setting the Sync Field Error Flag in the LIN Error Status register (LINESR[SFEF]) in case Sync Field value is not equal to 0x55, as per the Local Interconnect Network (LIN) specification.

The auto synchronization is only required when the baud-rate in the slave node can not be programmed directly in software and the slave node must synchronize to the master node baud rate.

#### Workaround

There are 2 possible workarounds.

Workaround 1:

When the LIN time-out counter is configured in LIN Mode by clearing the MODE bit of the LIN Time-Out Control Status register (LINTCSR[MODE]= 0x0):

1. Set the LIN state Interrupt enable bit in the LIN Interrupt Enable register (LINIER[LSIE] = 0b1)
2. When the Data Reception Completed Flag is asserted in the LIN Status Register (LINSR[DRF] = 0b1) read the LIN State field (LINSR[LINS])
3. If LINSR[LINS]= 0b0101, read the Counter Value field of the LIN Time-Out Control Status register (LINTCSR[CNT]), otherwise repeat step 2
4. If LINTCSR[CNT] is greater than 0xA, discard the frame.

When the LIN Time-out counter is configured in Output Compare Mode by setting the LINTCSR[MODE] bit:

1. Set the LIN State Interrupt Enable bit in the LIN Interrupt Enable register (LINIER[LSIE])
2. When the Data Reception Completed flag bit is asserted in the LIN Status Register (LINSR[DRF] = 0b1), read the LINSR[LINS] field
3. If LINSR[LINS] = 0b0101, store LINTCSR[CNT] value in a variable (ValueA), otherwise repeat step 2
4. Clear LINSR[DRF] flag by writing LINSR[LINS] field with 0xF
5. Wait for LINSR[DRF] to become asserted again and read LINSR[LINS] field
6. If LINSR[LINS] = 0b0101, store LINTCSR[CNT] value in a variable (ValueB), else repeat step 4
7. If ValueB - ValueA is greater than 0xA, discard the frame

Workaround 2:

Do not use the auto synchronization feature (disable with LINCR1[LASE] = 0b0) in LIN slave mode.

### **ERR008938: LINFlexD: Corruption of Tx data in LIN mode with DMA feature enabled (applicable to LIN1)**

#### **Description**

The LINFlexD module is driven by two different clocks. The transmit/reception logic is controlled by the module clock (LIN\_CLK) and register accesses are controlled by the peripheral bus clock (PBRIDGE<sub>Ex</sub>\_CLK). In LIN mode, the re-synchronization of the "Idle on bit error" between the two clocks may cause the Direct Memory Access (DMA) Finite State Machine inside the LINFlexD module to move to the idle state while a transmission is in process. This unwanted idle state transition could lead trigger a new DMA request, potentially overwriting the Buffer Identifier Register (BIDR) and the Buffer Data Registers (BDRL and BDRM).

#### **Workaround**

Do not enable the "Idle on bit error" of LIN Control Register 2 (LINCR2[IOBE] = 0). Instead of using the "Idle on bit error", use the bit error interrupt of LIN Interrupt Enable Register (LINIER[BEIE] = 1) to trigger an Interrupt service routine and force the LIN into idle mode through software if needed.

### **ERR008939: LINFlexD: Tx through DMA can be re-triggered after abort in LIN/UART modes or can prematurely end on the event of bit error with LINCR2[IOBE] bit being set in LIN mode (applicable only for LIN1)**

#### **Description**

The LINFlexD module is driven by two different clocks. The transmit/reception logic is controlled by the module clock (LIN\_CLK) and register accesses are controlled by the peripheral bus clock (PBRIDGE<sub>Ex</sub>\_CLK). Due to possible synchronization issue between the two clock domains, there is a possibility that DMA transmission get stuck due to DMA Finite State Machine doesn't go into idle. This may occur in one of the following conditions:

- if an abort request is triggered (LINCR2[ABRQ]=1) in LIN or UART modes
- if idle on bit error feature is enabled (LINCR2[IOBE]=1) in LIN mode, and a bit error occurs.

DMA state machine will not generate any transaction, waiting for data transmission flag LINSR[DTF] to be set which will never occur.

## Workaround

If DMA is used:

- Bit error interrupt should be enabled through LINEIER[BEIE]. When an bit error interrupt is triggered, the interrupt service routine must either reset the DMA Tx channel enable (DMATXE) and the DMA Rx channel enable (DMARXE) registers
- if an abort is requested (LINCR2[ABRQ]=1) in LIN/UART mode, either reset DMATXE/DMARXE of LINFlexD after writing LINCR2 [ABRQ]

## ERR009028: C55FMC: Possibility of a false Address Encode Error during flash read-while-write operation

### Description

The Address Encode Error (AEE) logic compares the system bus access address (external to flash) with the flash array address (internal to flash) and under normal operation they should match. During flash read-while-write operations (RWW), it is possible for a Program or Erase operation to corrupt the Address Encode feature of the flash, and falsely give an AEE event. The false AEE event only occurs for RWW operations to partitions in the Low, Mid or High address spaces, and will only occur if the read and write occur both in Even RWW partitions (i.e. 0, 2, 4), or if the read and write occur both in Odd RWW partitions (i.e. 1, 3, 5).

The AEE event is mapped to FCCU non-critical fault 38 (NCF[38]) and the default configuration is no reaction. Note it is possible to configure a long or short reset to react to an AEE event.

Reads to even numbered RWW partitions while writing to odd numbered RWW partitions will not trigger this false AEE condition. Likewise, reads to odd numbered RWW partitions while writing to even numbered RWW partitions will not trigger this false AEE condition.

Reads and Writes to 256K blocks, do not show the address encode corruption issue.

Read Data and ECC Parity bits returned for these Reads while writing are valid and not corrupted.

### Workaround

The user should be aware that a false AEE event could be flagged for the erratum condition. The default state of the MCU will not react to such an AEE event so the user need only manage the event if,

- (A) the application software is reading and handling the C55FMC\_MCR[AEE] flag, or
- (B) the application software configures the FCCU to react to such an AEE event.

## ERR009076: FCCU: Fault Collection and Control Unit glitch filter behavior is indeterministic

### Description

The FCCU Error In (EIN) signal is asynchronous to the FCCU glitch filter and as there is no synchronisation logic between these domains there is a possibility of metastability leading to indeterministic filter behaviour.

### Workaround

As the behavior of the FCCU glitch filter may be unpredictable it must be bypassed at FCCU\_CTRL[FILTER\_BYPASS]. If the EIN signal is required an external glitch filter should be implemented.

## ERR009135: NPC: LPM Debug handshake does not work for STOP Mode using all TCK frequencies

### Description

If a debugger or other tool is connected to the microcontroller and enables the Low Power Mode handshake in the Nexus Port Controller 1 Port Configuration Register (NPC\_1 PCR[LP\_DBG] = 1), the MCU may not transition from STOP mode back to RUN mode if the JTAG Test Clock (TCK) is less than one-tenth (1/10) of the system frequency. Transitions to and from the normal STANDBY mode or transitions using the Low Power Subsystem (LPU), including into the LPU\_STOP, are not impacted and operate correctly.

### Workaround

Use a TCK frequency greater than one-tenth of the System Clock frequency if using a tool and transitioning into and out of the normal STOP mode.

## ERR009200: MC\_ME and LPU: JTAG TCK pin must be configured to ensure successful exit from STANDBY and LPU modes

### Description

If the JTAG Test Clock Input (TCK) pin is not driven, it is possible at the exit from STANDBY or LPU (Low Power Unit) modes the core clock(s) may not start. If this state occurs, the MCU can be reset via a power cycle or PORST pin. MCU will also recover if TCK pin is driven low externally.

### Workaround

There are 2 options for the workaround depending on whether a debugger is attached:

1. Debugger is detached:

- Prior to entering STANDBY or LPU modes, the input buffer of the TCK pad must be disabled in the Multiplexed Signal Configuration Register (SIUL2\_MSCR[IBE] = 0).
- To re-enable debug functionality at exit from STANDBY or LPU modes, the input buffer of the TCK pad must be enabled (SIUL2\_MSCR[IBE]=0b1).

Note for the 324MPABGA package TCK can be configured for pad 121 and pad 197 and is selected by JTAG\_SELECT.

2. Debugger is attached:

- When the debugger is connected it will drive TCK, hence there is no impact.

## ERR009321: ADC: Conversions may fail if Pre-Sampling is enabled

### Description

Analog to Digital conversions for ADC\_0 and ADC\_1 may fail if Pre-Sampling is enabled. In this case, the ADC output may be unreliable. The failure occurs at minimum sampling time and when the internal voltage sample selection (ADC\_x\_PSCR[PREVALn] = 0, 1 or 2) is configured for VSS\_HV\_ADCx, VDD\_HV\_ADCx/8 or VREFLx as pre-sample voltage (x = 0 or 1).

## Workaround

For ADC\_0 select one of the following workarounds

- Disable pre-sampling
- If pre-sampling is enabled increase sampling time to at least 375nS

For ADC\_1 select one of the following workarounds

- Disable pre-sampling
- If pre-sampling is enabled select pre-sample voltage  $ADC\_1\_PSCR[PREVALn] = 3$  (VDD\_HV\_ADC1\_REF)
- If pre-sampling is enabled increase sampling time to at least 375nS

## ERR009322: TDM: Erase of TDR flash block may be blocked by the TDM

### Description

Erase of a flash block associated with a Tamper Detect Region (TDR) may be improperly blocked by the Tamper Detect Module (TDM) in a system if the Hardware Security Module (HSM) is also performing a program or erase operation. When this occurs, the erase operation will be shown as complete with Program/Erase Good (C55FMC\_MCR.DONE=1 and C55FMC\_MCR.PEG=1), but the block will not be erased.

### Workaround

Avoid HSM program/erase operations when erasing a flash block covered by a TDR. Alternatively, when erase of a flash block is attempted, but it completes with C55FMC\_MCR.PEG=1 and is not erased, a new diary entry should be written before attempting to erase the flash block again.

## ERR009328: ENET: Not possible to set the entire range of the ENET Timer Compare Capture Register (ENET\_TCCR0[TCC] and ENET\_TCCR1[TCC])

### Description

It is not possible to set the ENET Timer Capture Compare range ENET\_TCCRn[TCC] to zero or close to zero. n=0 or 1

### Workaround

The range set for the ENET\_TCCRn[TCC] needs to be restricted to the following range

$$ENET\_ATINC[INC] \leq TCC \leq (ENET\_ATPER[PERIOD] - ENET\_ATINC[INC])$$

Note: If restriction is not followed the associated event/interrupt may not be generated

## ERR009335: IAHB: Default programming of Intelligent AHB Gasket pending read optimisation can lead to masters stalling or receiving incorrect or spurious data

### Description

The eDMA, ENET\_0/1, uSDHC, MLB, USB\_0/1 and e200z2 masters can stall, receive wrong read data or get a spurious read access when the masters initiates a back-to-back read accesses and the first access is found to have an uncorrectable End-to-end Error Correction Code (e2eECC). This occurs when the pending

read enabled optimization in the Intelligent AHB (IAHB) is enabled at the Bus Bridge Configuration Register PCM\_IAHB\_BE<sub>x</sub>[PRE\_y], which is the default configuration out of reset.

## Workaround

The following workaround are available for each master.

### DMA:

1) Clear Pending Read Enable bit for the eDMA (PCM\_IAHB\_BE0[PRE\_DMA]=0). Note: This workaround could have a small impact on performance

2) Set the Halt On Error bit DMA\_CR[HOE] within the DMA. With this the bus error on the first access will be correctly handled, the DMA will disregard the second access and ignore all further DMA requests.

### ENET0 and 1:

1) Clear Pending Read Enable bit for ENET\_0 (PCM\_IAHB\_BE0[PRE\_ENET]=0) and ENET\_1 (PCM\_IAHB\_BE1[PRE\_MLB]=0).

Note: This workaround could have a small impact on performance

### uSDHC:

1) Clear Pending Read Enable bit for uSDHC (PCM\_IAHB\_BE1[PRE\_uSDHC]=0).

Note: This workaround could have a small impact on performance

### MLB:

1) Clear Pending Read Enable bit for MLB (PCM\_IAHB\_BE1[PRE\_MLB]=0).

Note: This workaround could have a small impact on performance

### USB\_0 and USB\_1:

1) Clear Pending Read Enable bit for USB\_0 (PCM\_IAHB\_BE1[PRE\_USB0]=0) and USB\_1 (PCM\_IAHB\_BE1[PRE\_USB1]=0).

Note: This workaround could have a small impact on performance

### e200Z2:

1) Clear Pending Read Enable bit for Z2\_INST (PCM\_IAHB\_BE2[PRE\_Z2\_INST]=0) and Z2\_DATA (PCM\_IAHB\_BE2[PRE\_Z2\_DATA]=0).

Note: This workaround could have a small impact on performance

## **ERR009873: PFLASH: Calibration remap to flash memory not supported on 16KB and 32KB flash blocks in address range 0x00F90000-0x00FBFFFF**

### Description

The PFLASH module supports calibration remapping of a flash access to another on-chip flash address. UTEST flash, BAF, and secure flash blocks cannot be remapped nor can accesses to other flash blocks be rerouted to addresses in UTEST flash, BAF, or secure flash. Flash blocks of size 16KB and 32KB in address range 0x00F90000-0x00FBFFFF do not support calibration remap to flash memory. All other flash blocks of size 32KB, 64KB 256KB in address range 0x00FC0000-0x0157FFFF can be overlaid using the mirrored address range.

## Workaround

When using the calibration remapping of flash feature, the user must select flash blocks of size 32KB, 64KB 256KB in address range 0x00FC0000-0x0157FFFF.

## ERR009978: eMIOS: Unexpected channel flag assertion during GPIO to MCB mode transition

### Description

When changing an Enhanced Modular IO Subsystem (eMIOS) channel mode from General Purpose Input/Output (GPIO) to Modulus Counter Buffered (MCB) mode, the channel flag in the eMIOS Channel Status register (eMIOS\_Sn[FLAG]) may incorrectly be asserted. This will cause an unexpected interrupt or DMA request if enabled for that channel.

### Workaround

In order to change the channel mode from GPIO to MCB without causing an unexpected interrupt or DMA request, perform the following steps:

- (1) Clear the FLAG enable bit in the eMIOS Control register (eMIOS\_Cn[FEN] = 0).
- (2) Change the channel mode (eMIOS\_Cn[MODE]) to the desired MCB mode.
- (3) Clear the channel FLAG bit by writing '1' to the eMIOS Channel Status register FLAG field (eMIOS\_Sn[FLAG] = 1).
- (4) Set the FLAG enable bit (eMIOS\_Cn[FEN] = 1) to re-enable the channel interrupt or DMA request reaction.

## ERR009995: DSPI0 and DSPI1: Frame transfer does not restart in case of DSI parity error in master mode

### Description

In the Serial Peripheral Interface module, in the scenario when:

1. Master/slave mode select bit of module configuration register is set (MCR[MSTR]=0b1) to configure the module in master mode
2. Deserial Serial Interface (DSI) communication is selected via DSPI Configuration field (DCONF) in MCR (MCR[DCONF] = 0b01)
3. Parity reception check on received DSI frame is enabled by setting Parity Enable bit (PE) of DSI configuration register 0 (DSICR0[PE]=0b1)
4. Parity Error Stop (PES) bit of DSI configuration register0 is set (DSICR0[PES]=0b1) which stops DSI frame transfer in case of parity error
5. Parity error is detected on received frame

Then the next frame transfer is stopped, DSI parity error flag bit of status register is set (SR[DPEF] =0b1) and the corresponding DSI parity error interrupt is asserted. Even after the interrupt is serviced and SR [DPEF] is reset, the frame transfer does not restart.

## Workaround

DSI frame transfer stop in case of parity error detection should be disabled. For this, keep the parity error stop bit of DSI configuration register0 de-asserted (DSICR0 [PES]=0b0).

### **ERR009996: DSPI0 and DSPI1: Frame transfer does not restart after DSI frame matches preprogrammed value**

#### Description

In the Deserial Serial Peripheral Interface module, in the scenario when:

1. Master/slave mode select bit of module configuration register is set (MCR[MSTR]=0b1) to configure the module in master mode
2. Deserial Serial Interface (DSI) communication is selected via DSPI Configuration field (DCONF) in the Module Configuration Register (MCR [DCONF] = 0b01)
3. Preprogrammed value for data match with received DSI frame is configured using DSI De-serialized Data Polarity Interrupt Register (DPIR) and DSI De-serialized Data Interrupt Mask Register (DIMR)
4. Data Match Stop (DMS) bit of DSI configuration register0 is set (DSICR0 [DMS] =0b1) which stops DSI frame transfer in case of a data match with a preprogrammed value
5. DSI frame is received with bits matching preprogrammed value.

Under these conditions, the next frame transfer is stopped, DSI Data Received with Active Bits bit of status register is set (SR [DDIF] =0b1) and the corresponding DDIF interrupt is asserted. Even after the interrupt is serviced and SR [DDIF] is reset, the frame transfer does not restart.

#### Workaround

DSI frame transfer stop in case of DSI data match condition should be disabled. For this, keep the data match stop bit of DSI configuration register 0 de-asserted (DSICR0 [DMS]=0b0)

### **ERR010118: HSM: TRNG can only select FIRC for clock source**

#### Description

The user must not select FXOSC as a clock source for the HSM TRNG. The HSM TRNG clock source is selected at MC\_CGM\_AC3\_SC[SELCTL].

#### Workaround

The user should select the FIRC for the HSM TRNG clock by clearing MC\_CGM\_AC3\_SC[SELCTL] (this is the default setting)

### **ERR010132: LPU: Mode transition to LPU\_STOP or LPU\_STANDBY may not complete**

#### Description

A mode transition from LPU\_RUN to LPU\_STOP or LPU\_RUN to LPU\_STANDBY may not complete if a wake-up or interrupt is received in a 5 FIRC clock window after the mode transition is requested. This is only applicable if the FIRC is disabled in LPU\_STOP and LPU\_STANDBY. In this scenario, the z2 core is stopped

and if the System Watchdog Timer (SWT) is enabled, the SWT continues to run, the SWT will timeout and a SWT destructive reset will be triggered.

### Workaround

The user can select one of the following workarounds:

1. Enable the SWT during LPU modes to enable recovery through destructive reset
2. Enable the FIRC in LPU\_STOP and LPU\_STANDBY

## **ERR010141: LPU: LPU\_RUN mode system clock must be preconfigured for undivided FIRC prior to LPU\_STANDBY entry**

### Description

If the LPU\_RUN mode system clock is selected to be FXOSC or divided-FIRC when LPU\_STANDBY mode is entered then the MCU may not return to LPU\_RUN mode on a wake-up event.

In LPU\_RUN mode the FXOSC or divided-FIRC can be used as the system clock, but the user must ensure that the undivided FIRC is selected as the system clock before the LPU\_STANDBY mode transition is initiated.

### Workaround

Prior to entering LPU\_STANDBY select undivided FIRC as the LPU System Clock by configuring LPU\_RUN\_CF[SYS\_CLK\_SEL] = 0 and FIRC\_CTL[FIRCDIV] = 5'b0.

## **ERR010143: CMP\_0: At exit from STANDBY the output of Comparator 0 is configured to high-impedance**

### Description

Irrespective of the configuration of GPR\_CTL[`CMP0_STDBY`] the output of the Comparator 0 (`CMP0_O`) will be configured to high-impedance when the MCU exits STANDBY. As a result the Comparator output value is not valid until the `CMP_0` is reconfigured in the subsequent RUN mode.

### Workaround

To retain the Comparator output value during STANDBY mode and during the STANDBY exit sequence to DRUN, the Pad Keeper function can be enabled at `PMCDIG_RDCR[PAD_KEEP_EN]`.

For the case the Pad Keeper is enabled:

- (1) The Comparator 0 output will be static whilst in STANDBY mode.
- (2) The Pad Keeper function affects all outputs in the STBY\_LPU power segment.

## **ERR010215: DSPI0/1 and SPI0/3 : Frame transfer does not restart in case of SPI parity error in master mode**

### Description

In the Deserial Serial Peripheral Interface (DSPI) module, in the scenario when:

1. Master/slave mode select bit (MSTR) of Module Configuration register (MCR) is set (MCR[MSTR]=0b1) to configure the module in master mode
2. SPI communication is selected via DSPI Configuration field (DCONF) in MCR (MCR[DCONF] = 0b00)
3. Parity reception check on received frame is enabled by setting the Parity Enable or Mask tASC delay (PE\_MASC) bit of DSPI PUSH FIFO Register In Master Mode (PUSHR), i.e. PUSHR[PE]=0b1.
4. Parity Error Stop bit (PES) of MCR is set (MCR[PES]=0b1) which stops SPI frame transfer in case of parity error
5. Parity error is detected on received frame.

Then the next frame transfer is stopped, the SPI Parity Error Flag bit (SPEF) of the DSPI Status Register (DSPI\_SR) is set (SR[SPEF] =0b1) and the corresponding SPI parity error interrupt is asserted. Even after the interrupt is serviced and SR[SPEF] is reset, the frame transfer does not restart.

### Workaround

Do not use SPI frame transfer stop in case of parity error detection for SPI transmission in master mode. For this, keep the Parity Error Stop bit of Module Configuration Register de-asserted (MCR[PES] = 0b0).

### **ERR010323: MC\_ME: The transition from DRUN/RUN mode to STANDBY will not complete if a wake-up is triggered in a 50nS window.**

### Description

At the DRUN/RUNx to STANDBY mode transition there are 2 windows (each 50nS typical) at which time if a WKPU (wake-up) occurs the mode transition will not complete. The 2 windows occur in the STANDBY entry transition period (20uS typical) - this period is from the mode transition request at the MC\_ME\_MCTL register to a toggle of the EXTREGC (External Regulator Control) pin. The EXTREGC pin signals the low power transition is complete.

For the case the mode transition does not complete the MCU will be stuck in reset (window #1) or stuck in STANDBY (window #2) and will only recover via a power-cycle of VDD\_HVA.

### Workaround

Ensure wake-ups are not triggered in the STANDBY entry transition period during the DRUN to STANDBY mode transition, by adhering to all of the following:

- If the application cannot guarantee to avoid triggering an external wake-up during the STANDBY entry transition period, prior to entering STANDBY mode all external wake-ups must be disabled.
- Application SW should use a periodic wake-up (RTC-API) and poll WKPU\_WISR. If a wake-up is recorded at WKPU\_WISR this signals to the application SW that an external wake-up has occurred whilst in STANDBY mode.
- The RTC-API timer must not timeout during the STANDBY entry transition period.

Alternatively, use an unaffected mode

- a) LPU\_STANDBY(FIRC-on) rather than STANDBY. In LPU\_STANDBY mode, external wake-ups can be enabled (see also e10132).
- b) STOP mode.

## ERR010340: NZxC3: ICNT and HIST fields of a Nexus message are not properly reset following a device reset

### Description

Following reset, if instruction trace is enabled in the Nexus e200zx core Class 3 trace client (NZxC3), the e200zx core transmits a Program Trace - Synchronization Message (PT-SM). The PT-SM includes the full execution address and the number of instructions executed since the last Nexus message (ICNT) information. However, if Branch History trace is enabled, the ICNT and the Branch History (HIST) fields are not properly cleared when this message is transmitted. This may cause unexpected trace reconstruction results until the next Nexus Program Trace Synchronization Message (Program Trace - Direct Branch Message with Sync, Program Trace - Indirect Branch Message with Sync, or Program Trace - Indirect Branch History Message with Sync).

In Branch History mode, the first indirect branch following the reset (and the initial PT-SM) will contain the branch history prior to the reset plus the branch history after reset. However, there is no way to determine which branches occurred prior to reset and which followed reset.

### Workaround

If not using branch history trace mode, to recreate the proper trace, the tool should take into account that the ICNT field is not cleared by the first PT-SM. The previous ICNT will be added to new ICNT value in the subsequent Nexus message. This may require extra processing by the tool.

If using branch history mode, then an accurate reconstruction of the executed code just before and just after reset may not be possible. Trace reconstruction can be recovered after the next indirect branch message.

On devices that bypass the Boot Assist Flash (BAF), Boot Assist Module (BAM), or BootROM after reset, perform an indirect branch instruction shortly after reset to reset the ICNT (and HIST if Branch History mode is enabled). Also, A full program trace synchronization message will be generated after 256 direct branches even if there is no indirect branches. This will allow the tool to recover the trace reconstruction from that point onward.

On devices that always execute boot from boot ROM firmware, the BAF or BAM, an indirect branch will occur during the boot ROM/BAF/BAM execution and the tool trace will be re-synchronized prior to the execution of user code.

## ERR010361: MC\_ME & LPU: The transition between DRUN/RUN mode to STANDBY or DRUN/RUN mode to LPU\_RUN may not complete if EXR is asserted.

### Description

At the DRUN/RUNx to STANDBY transition there are 2 windows (each 50nS typical) at which time if the External Reset (EXR) is asserted, the mode transition will not complete. The 2 windows occur in the STANDBY entry transition period (20uS typical) - this period is from the mode transition request at the MC\_ME\_MCTL register to a toggle of the EXTREGC (External Regulator Control) pin. The EXTREG pin signals the low power transition is complete.

At the DRUN/RUN to LPU\_RUN transition there are 3 windows:

1. A single window, 686nS (typical) for DRUN-FIRC or 236nS (typical) for DRUN-FMPLL160MHZ.
2. Plus 2 other windows each 50nS typical.

If EXR is asserted in any of the 3 windows the mode transition will not complete. The 3 windows occur in the LPU\_RUN entry transition period (20uS typical) - this period is from the mode transition request at the MC\_ME\_MCTL register to a toggle of the EXTREGC pin.

For the case the mode transition does not complete the MCU will be stuck in reset or stuck in STANDBY and will only recover via a power-cycle of VDD\_HVA.

### Workaround

1. Ensure that External Reset (EXR) is not triggered during the windows of susceptibility at the entry to STANDBY mode or at the entry to LPU\_RUN mode.
2. Alternatively, use the unaffected low power mode STOP.

## **ERR010362: MC\_ME & LPU: The transition between DRUN/RUN mode to STANDBY or DRUN/RUN mode to LPU\_RUN may not complete if any LVD is asserted or PORST goes low**

### Description

At power-up to DRUN there is a window (50nS typical) at which time if any of the Low Voltage Detects (LVDs) are asserted or PORST goes low, the mode transition will not complete.

At the DRUN/RUNx to STANDBY transition or DRUN/RUN to LPU\_RUN there are 2 windows (each 50nS typical) at which time if any of the LVDs are asserted, the mode transition will not complete. The 2 windows occur in the STANDBY/LPU entry transition period (20uS typical) - this period is from the mode transition request at the MC\_ME\_MCTL register to a toggle of the EXTREGC (External Regulator Control) pin. The EXTREG pin signals the low power transition is complete.

For the case the mode transition does not complete the MCU will be stuck in reset and will only recover via a power-cycle of VDD\_HVA.

Upon wake-up from STANDBY or LPU\_RUN modes there is a single window (50nS typical) at which time if any of the LVDs are asserted or PORST is asserted, the mode transition will not complete. This window occurs in the STANDBY/LPU exit transition period (12uS typical) immediately after assertion of the wake-up signal. For this case when the mode transition does not complete the MCU will be stuck in reset and recover via a power-cycle of VDD\_HVA.

### Workaround

1. Ensure that no Low Voltage Detect (LVD) is triggered or PORST goes low during the windows of susceptibility at Power-up, at the entry to STANDBY mode, at the exit of STANDBY, at the exit of LPU modes, or at the entry to LPU\_RUN mode.
2. Alternatively, use the unaffected low power mode STOP.

## **ERR010368: FlexCAN: Transition of the CAN FD operation enable bit may lead FlexCAN logic to an inconsistent state.**

### Description

The activation or deactivation of the CAN FD operation by setting or clearing the FDEN bit of the CAN\_MCR register or by setting the FlexCAN soft reset bit (SOFTTRST) of the CAN\_MCR register when the FDEN bit is enabled may cause an internal FlexCAN register to become metastable. As result, the first CAN frame, transmitted or received, may have corrupted data (ID and payload). However, even though the data is corrupted, a valid CAN frame is transmitted because the Cyclic Redundancy Check (CRC) calculation is based on the corrupted data. During reception the data is corrupted internally after the CRC bits have been checked

and therefore this corrupted data may be stored in a reception message buffer. After the first CAN frame, all subsequent frames are transmitted and received correctly.

### Workaround

Perform the following steps to set the FDEN bit:

1. If FlexCAN is already in freeze mode, go to step 3, otherwise set the HALT and FRZ bits of the CAN\_MCR register.
2. Wait the FRZACK bit of the CAN\_MCR register to be set by the hardware.
3. Set the LPB (Loop Back Mode) bit of the CAN\_CTRL1 register.
4. Configure only one message buffer to be transmitted. The frame should be a classical one (non-FD) with IDE =0, RTR =1 DLC =0x5 and STD\_ID =0x682.
5. Set the FDEN bit of the CAN\_MCR register.
6. Clear the HALT bit of the MCR register to leave freeze mode.
7. Wait the FRZACK bit of the CAN\_MCR register to be cleared by the hardware.
8. Wait the respective bit of the CAN\_IFLAG register to be set (successfully transmission in loop back mode).
9. Clear the respective bit of the CAN\_IFLAG register by writing 1.
10. Set the HALT and FRZ bits of the CAN\_MCR register.
11. Wait the FRZACK bit of the CAN\_MCR register to be set by the hardware.
12. Clear the LPB (Loop Back Mode) bit of the CAN\_CTRL1 register.

Perform the following steps to apply a soft reset or clear the FDEN bit:

1. If FlexCAN is already in freeze mode, go to step 3, otherwise set the HALT and FRZ bits of the CAN\_MCR register.
2. Wait the FRZACK bit of the CAN\_MCR register to be set by the hardware.
3. Set the SOFTRST bit of the CAN\_MCR register.
4. Wait the SOFTRST bit of the CAN\_MCR register to be cleared by the hardware.
5. Set again the SOFTRST bit of the CAN\_MCR register.
6. Wait the SOFTRST bit of the CAN\_MCR register to be cleared by the hardware.

### ERR010385: e200z4: Incorrect branch displacement at 16K memory boundaries

#### Description

The branch target address will be incorrectly calculated in the e200z4 core under the following conditions (all conditions must be matched):

- The first full instruction in a 16 Kbyte section/page of code is a 32-bit long branch with a branch displacement value with the lower 14 bits of the displacement exactly 0x3FFE
- And this branch instruction is located at byte offset 0x0002 in the section/page
- And the preceding instruction is a 32-bit length instruction which is misaligned across the 16K boundary
- And both instructions are dual-issued

Under these conditions, the branch target address will be too small by 32Kbytes.

## Workaround

After software is compiled and linked, code should be checked to ensure that there are no branch instructions located at address 0x2 of any 16K memory boundary with the lower 14 bits of the displacement equal to 0x3FFE if preceded a 32-bit instruction that crosses the 16K memory boundary. If this sequence occurs, add a NOP instruction or otherwise force a change to the instruction addresses to remove the condition.

A tool is available on [nxp.com](http://nxp.com) that can be run to examine code for this condition, search for `branch_displacement_erratum_10385_checker`.

## ERR010396: PASS: Password challenge to PASS fails while program erase ongoing in any block in memory partition 0

### Description

If the device is in a Censored state (enabled by programming the censorship DCF in UTEST) and a JTAG password is configured to enable device debug access, then the password challenge to the PASS module would be initiated by programming the Challenge Selector Register (PASS\_CHSEL) to determine the password group, then programming the Challenge Input Registers (PASS\_CINn) with the correct password. Programming the correct password would then allow enabling of debug interface access.

However, this operation will fail if a program or erase operation is ongoing on any flash block in memory partition 0, since this is shared with the UTEST block where the JTAG password resides.

### Workaround

Users should ensure that no program or erase operations are occurring on any memory partitions shared with the UTEST block before initiating a password challenge. This can be monitored through the flash module configuration register program and erase status bits (C55FMC\_MCR[PGM], C55FMC\_MCR[ERS]).

## ERR010413: HSM: HSM RAM initialization clock out of specification when Accelerated Low Power Exit is enabled with FMPLL = 160MHz

### Description

The HSM RAM will be clocked greater than the 80MHz maximum specification for the following configuration

- The HSM RAM initialization is enabled, and
- Accelerated Low Power Exit is configured to use the FMPLL at 160MHz

At the exit from low power mode prior to DRUN mode entry, the FMPLL will be preconfigured to run at 160MHz. In this phase prior to the DRUN mode the HSM RAM will be initialized with the 160MHz clock. This may result in the incorrect initialization of the HSM RAM and thus the reporting of ECC errors.

### Workaround

For the erratum configuration described the HSM RAM clock specification can be adhered to if the FMPLL is preconfigured for 80MHz for the Accelerated Low Power Exit. Note the FMPLL must be configured in a RUN mode prior to the low power mode entry.

**ERR010440: MC\_ME & LPU: The transition between DRUN/RUN mode to STANDBY or DRUN/RUN mode to LPU\_RUN may not complete if a reset is asserted.****Description**

The following reset sources can cause the errata condition but all can either be disabled via a control register or avoided as they are triggered by software.

Destructive Resets indicated at MC\_RGM\_DES:

- Software Watchdog Timer 0, MC\_RGM\_DES[F\_SWT0\_RES]
- Software Watchdog Timer 1, MC\_RGM\_DES[F\_SWT1\_RES]
- Software Watchdog Timer 2, MC\_RGM\_DES[F\_SWT2\_RES]

Functional Resets indicated at MC\_RGM\_FES:

- Non Maskable Interrupt from Wakeup Unit, MC\_RGM\_FES[F\_NMI\_WKPU]
- Clock Monitor Unit FXOSC less than FIRC, MC\_RGM\_FES[F\_CMU\_OLR]
- Fault Collection and Control Unit Long Functional Reset, MC\_RGM\_FES[F\_FCCU\_LONG]
- Fault Collection and Control Unit Short Functional Reset, MC\_RGM\_FES[F\_FCCU\_SHORT]
- VDD\_HV\_A Low Voltage Detect, MC\_RGM\_FES[F\_LVD\_IO\_A\_HI]
- High Voltage Detect, MC\_RGM\_FES[F\_HVD\_LV\_cold]
- Power Domain 2 Low Voltage Detect, MC\_RGM\_FES[F\_LVD\_LV\_PD2\_cold]

At the DRUN/RUNx to STANDBY transition there are 2 windows (each 50nS typical) at which time if any of the listed resets are asserted, the mode transition will not complete. The 2 windows occur in the STANDBY entry transition period (20uS typical) - this period is from the mode transition request at the MC\_ME\_MCTL register to a toggle of the EXTREGC (External Regulator Control) pin. The EXTREG pin signals the low power transition is complete.

At the DRUN/RUN to LPU\_RUN transition there are 3 windows:

1. A single window, 686nS (typical) for DRUN-FIRC or 236nS (typical) for DRUN-FMPLL160MHZ.
2. Plus 2 other windows each 50nS typical.

If any of the listed resets are asserted in any of the 3 windows the mode transition will not complete. The 3 windows occur in the LPU\_RUN entry transition period (20uS typical) - this period is from the mode transition request at the MC\_ME\_MCTL register to a toggle of the EXTREGC pin.

For the case the mode transition does not complete the MCU will be stuck in reset or stuck in STANDBY and will only recover via a power-cycle of VDD\_HVA.

**Workaround**

Prior to transitioning to STANDBY or LPU\_RUN mode the application should:

Configure the following reset sources so they cannot be triggered in the window of susceptibility:

- Software Watchdog Timer 0, MC\_RGM\_DES[F\_SWT0\_RES]
- Software Watchdog Timer 1, MC\_RGM\_DES[F\_SWT1\_RES]
- Software Watchdog Timer 2, MC\_RGM\_DES[F\_SWT2\_RES]

Disable the following reset sources:

- Functional Reset Escalation, MC\_RGM\_FES[F\_FUNC\_ESC]
- Non Maskable Interrupt from Wakeup Unit, MC\_RGM\_FES[F\_NMI\_WKPU]
- Clock Monitor Unit FXOSC less than FIRC, MC\_RGM\_FES[F\_CMU\_OLR]
- Fault Collection and Control Unit Long Functional Reset, MC\_RGM\_FES[F\_FCCU\_LONG]
- Fault Collection and Control Unit Short Functional Reset, MC\_RGM\_FES[F\_FCCU\_SHORT]
- VDD\_HV\_A Low Voltage Detect, MC\_RGM\_FES[F\_LVD\_IO\_A\_HI]
- High Voltage Detect, MC\_RGM\_FES[F\_HVD\_LV\_cold]
- Power Domain 2 Low Voltage Detect, MC\_RGM\_FES[F\_LVD\_LV\_PD2\_cold]

### **ERR010452: eDMA: When master ID replication is enabled, the stored ID and privilege level will change if read by another master.**

#### **Description**

When master ID replication is enabled (DMA\_DCHMIDn[EMI]=1), the DMA\_DCHMIDn[PAL] and DMA\_DCHMIDn[MID] fields should reflect the privilege level and master ID respectively of the master that wrote the DMA\_TCDn\_CSR[DONE:START] byte. However, if a different master reads the DMA\_TCDn\_CSR[DONE:START] byte, the master ID and privilege level will incorrectly change to this read access.

#### **Workaround**

Only allow the intended master ID replication core to access the DMA\_TCDn\_CSR[DONE:START] byte.

### **ERR010542: DSPI: Transmit, Command, and Receive FIFO fill flags in status register is not cleared when DMA is improperly configured**

#### **Description**

The Deserial/Serial Peripheral Interface Transmit, Receive, and Command First In/First Out (FIFO) buffers can request additional information to be transferred via the Direct Memory Access (DMA) module when either the Transmit, Receive, or Command FIFO Fill/Drain Flags are set in the DSPI Status Register (SR[TFFF/RFDF/CMDFFF]). However, the Command/Transmit Fill Flag only indicates that at least 1 location in the FIFO is available to be written. It does not indicate that the FIFO is empty. Similarly, Receive FIFO fill flag only indicates at least 1 location of the FIFO is available to be read. It does not indicate that the FIFO is full. If the DMA is configured to transfer more than 1 FIFO location size of data, the FIFO Fill Flags may not be properly cleared indicating that the FIFO is not full even when the FIFO is actually full (for Transmit and Command FIFO) and not empty when the FIFO is actually empty (for Receive FIFO).

#### **Workaround**

Properly configure the DMA to fill the Transmit, Receive, and Command FIFOs only one FIFO location, in other words, up to 2 bytes, at a time to each of the FIFOs.

Use the DMA loop to transfer more data if needed.

**ERR010590: PLL: Might remain unlocked when enabled after Standby or power on****Description**

When enabled after an event where the following conditions are met, the PLL might fail to lock:

- 1.- VDD\_LV (1.2 V) was disabled
- 2.- A Pre-divider of 1 (PLLDIG\_PLLDV[PREDIV] = 0 or 1) is used
- 3.- The PLL is clocked from the fast external oscillator (FXOSC)

Common situations in which VDD\_LV might be disabled are Standby and power-off of the device.

**Workaround**

There are three ways to avoid this:

- 1.- Avoid using a pre-divider of 1 (PLLDIG\_PLLDV[PREDIV] = 0 or 1) and instead use a value of 2.
- 2.- During Standby leave the supply to VDD\_LV enabled.
- 3.- Initialize the PLL using the fast internal oscillator (FIRC) as source clock and then switch to use the fast external oscillator (FXOSC).

**ERR010594: ENET: The ENET1 (Ethernet) module does not function unless the Peripheral control register (MC\_ME\_PCTL6) is enabled .****Description**

The Ethernet module ENET1 does not function unless the MLB Peripheral control register (MC\_ME\_PCTL6) is enabled. This does not apply to ENET0.

**Workaround**

Enable MC\_ME\_PCTL6 if using the ENET1 module.

**ERR010595: FlexCAN: FLEXCAN1-7 modules will not work unless the Fast External Oscillator (FXOSC) clock source is enabled****Description**

FLEXCAN modules 1-7 will not work unless the Fast External Oscillator (FXOSC) clock source is enabled on the device.

**Workaround**

The FXOSC clock should be enabled before using FLEXCAN1-7 modules by setting the Oscillator Enable bit (FXOSCON) in the active mode configuration register (MC\_ME\_xxxx\_MC).

## ERR010603: NPC: Nexus Port Controller (NPC) must be enabled to allow mode changes during debug

### Description

The Nexus Port Controller (NPC) must be enabled to allow mode changes via the Mode Entry module in debug mode. The e200zx core generates some Nexus trace messages automatically even when trace is not enabled if a Nexus Enable instruction is executed (typically used for Nexus read/write access of memory by a tool). As a result, if the NPC is not enabled, the core will still see messages pending and never complete the requested mode change.

### Workaround

Enable the NPC by enabling the Message Clock Output (MCKO\_EN = 1) in the NPC Port Configuration Register (NPC\_PCR).

## ERR010609: MC\_CGM: CLKOUT\_0 and CLKOUT\_1 may stop if the clock selection is changed when configured for divide by 2

### Description

If the clock out functionality is enabled on either CLKOUT\_0 and/or CLKOUT\_1 and is configured for divide by 2 (via MC\_CGM\_AC6\_DC0[DE] and/or MC\_CGM\_CLKOUT1\_DC0[DE] = 0b1), then if the clock selection for CLKOUT\_0/CLKOUT\_1 is changed via MC\_CGM\_AC6\_SC[SELCTL]/MC\_CGM\_CLKOUT1\_SC[SELCTL] register respectively or a Destructive, Functional (long/short) reset occurs then the clock out may stop. The following clock sources when selected are affected:

- FXOSC
- FXOSC divided
- FXOSC ANA Clk
- SXOSC
- SXOSC divided
- SIRC
- SIRC divided
- PLL\_CLKOUT1
- PLL\_CLKOUT2
- RTC\_CLK
- CAN0 CHI clk (when driven by FXOSC, not affected when driven by FS80)
- CAN0 PE clk (when driven by FXOSC, not affected when driven by F40)

### Workaround

Changing CLKOUT\_0/CLKOUT\_1 clock source selection value via software, resets all its corresponding dividers and recovers them.

Apply the following sequence after each reset for enabled CLKOUT\_0/CLKOUT\_1 clock dividers that are to be configured to divide by 2 for the application.

1. Disable the CLKOUT\_0 and/or CLKOUT\_1 clock divider by writing to MC\_CGM\_AC6\_DC0[DE] and/or MC\_CGM\_CLKOUT1\_DC0[DE] = 0b0
2. Change the CLKOUT\_0 and/or CLKOUT\_1 clock source selection to FIRC (MC\_CGM\_AC6\_SC[SELCTL] = 0b0001 and/or MC\_CGM\_CLKOUT1\_SC[SELCTL] = 0b1001).
3. Select the desired clock source as the CLKOUT\_0 and/or CLKOUT\_1 clock source (e.g. for FXOSC: MC\_CGM\_AC6\_SC[SELCTL] = 0b0000 and/or MC\_CGM\_CLKOUT1\_SC[SELCTL] = 0b1000).
4. Configure and enable the corresponding CLKOUT\_0 and/or CLKOUT\_1 clock divider by writing to MC\_CGM\_AC6\_DC0[DE] and/or MC\_CGM\_CLKOUT1\_DC0[DE] = 0b1.

## **ERR010620: FlexRay: The FS80 clock source should not be selected for the FlexRay protocol clock when the MCU clocking is configured for Linear Dynamic Frequency Scaling**

### **Description**

The FlexRay module protocol clock can be selected from the FXOSC clock (default) or the FS80 clock and this is configured at FR\_MCR[CLKSEL]. When the MCU clock configuration is changed from the default state to the Linear DFS (Dynamic Frequency Scaling) clock mode, the FS80 must not be selected as the source for the FlexRay protocol clock.

### **Workaround**

Prior to configuring the Linear DFS clock mode the user must select FXOSC for the FlexRay protocol clock.

## **ERR010723: NPC: Repeated Nexus3 Debug Status messages can be observed if more than one master (including a device core) is active and the core is subsequently disabled**

### **Description**

This errata applies to the condition where there is more than one master active on the Nexus Port Controller (NPC) module, and one or more of these masters is a device core. In this situation, if a mode transition is initiated to a mode where that device core is disabled, with the clock gated (as configured in the relevant core control register MC\_ME\_CCTLx for the requested mode) then message data can be left pending on the interface until the core clock resumes. This causes status message to be repeated several times and no other message from any other Nexus3 client can be transmitted causing potential debugger problems.

### **Workaround**

While transitioning to a low power mode (STOP, STANDBY, LPU\_RUN), use the NPC Handshake by clearing NPC\_1 PCR [LP1\_SYNC] bit. The debugger can then disable the Nexus3 tracing of the core before it acknowledges that the transition into a low-power mode may proceed. For a non-low power mode transition (DRUN, RUNx), do not disable device core but instead use the Power Architecture 'wait' instruction to move the device core to the wait state.

Alternatively, transmit repeated or more than one TCODE messages from the active masters.

**ERR010789: PFLASH: EEPROM ECC error suppression is not supported on 16KB and 32KB flash blocks in the address range 0x00F90000-0x00FBFFFF****Description**

The PFLASH module supports the suppression of ECC event reporting on secure data flash blocks in the address range 0x00F80000 – 0x00F87FFF. For more information see MPC5748G Reference Manual section "ECC on data flash accesses". Flash blocks of size 16KB and 32KB in address range 0x00F90000 – 0x00FBFFFF do not support suppression of error reporting on ECC events. When reading from the address range 0x00F90000-0x00FBFFFF any non-correctable ECC error will be reported as a bus error to the requesting master. Both correctable and non-correctable ECC errors are reported to the MEMU.

**Workaround**

The application software must handle bus errors due to non-correctable ECC errors in the flash memory region 0x00F90000 – 0x00FBFFFF.

**ERR010963: Flash: Memory accesses may be corrupted when flash is operating between 33MHz and 75MHz****Description**

Error Correction Code (ECC) errors may be generated in the flash due to corrupted data when all of the following conditions are met:

- The flash operating frequency is greater than 33MHz and less than or equal to 75MHz
- Read Wait State Control (PFLASH\_PFCR1[RWSC]) = 2 and Address Pipeline Control (PFLASH\_PFCR1[APC]) = 1
- Pipelined reads which are executed between the UTEST flash block and any other flash block. Pipelined reads are overlapping reads, where before the previous read is completed a new read is requested.

Device has UTEST memory space and remaining flash area is the main array memory space. This issue condition occurs if pipelined reads are executed between UTEST and the main array space. If pipelined reads are executed between UTEST and UTEST memory space or between main array and main array memory space, this issue condition will not be seen.

**Workaround**

When the flash clock frequency is greater than 33MHz and less than or equal to 75MHz configure PFLASH\_PFCR1[RWSC] = 2 and PFLASH\_PFCR1[APC] = 0. The configuration for all other flash clock frequencies is specified in the MCU datasheet.

**ERR011046: ENET: The timer mode ENETx\_TCSRn[TMODE] settings 1010 and 1001 are unusable****Description**

The following timer modes are unavailable in ENET0\_TCSRn[TMODE] and ENET1\_TCSRn[TMODE]:

1010: Timer Channel is configured for Output Compare - clear output on compare, set output on overflow.

1001: Timer Channel is configured for Output Compare - set output on compare, clear output on overflow.

## Workaround

The user must refrain from using these timer modes when using ENET0 and ENET1, and instead use another available mode.

### **ERR011096: SAI: Internal bit clock is not generated when RCR2[BCI]=1 or TCR2[BCI]=1**

#### Description

When the SAI transmitter or receiver is configured for internal bit clock with BCI = 1, the bit clock is not generated for either of the following two configurations:

- a) SYNC = 00 and BCS = 0
- b) SYNC = 01 and BCS = 1

#### Workaround

When the SAI transmitter or receiver is configured for internal bit clock with BCI=1, use only one of the following two configurations:

- a) SYNC = 01 and BCS = 0
- b) SYNC = 00 and BCS = 1

### **ERR011150: SAI: Internally generated receive or transmit BCLK cannot be re-enabled if it is first disabled when RCR2[DIV] or TCR2[DIV] > 0**

#### Description

If the receive or transmit bit clock (BCLK) is internally generated, enabled with DIV > 0 and is then disabled, due to software or Stop mode entry, and the BCLK is enabled again, the clock is not generated.

#### Workaround

If the receive or transmit BCLK is internally generated and a DIV value greater than 0 is used, the SAI must be reset before the BCLK is re-enabled. This is achieved by writing the SR bit in the respective RCSR or TCSR register first to 1 and then immediately to 0.

### **ERR011235: EMIOs: Any Unified Channel running in OPWMB or OPWMCB mode may function improperly if the source counter bus is generated by Unified channel in MC mode**

#### Description

The Unified channel (UC) configured in Center Aligned Output Pulse Width Modulation Buffered (OPWMCB) or Output Pulse Width Modulation Buffered (OPWMB) modes is not working properly when it is sourced from the UC configured in Modulus Counter (MC) mode by setting the channel control register MODE bitfield to 0x10 or 0x11 and any of its pre-scalers (internal or global) divider ratio is higher than 1.

#### Workaround

When a counter bus is generated by the UC set in the MC mode with any pre-scaler (internal or global) divider ratio higher than 1, don't use this counter bus for the UC set in OPWMCB or OPWMB mode.

## ERR011287: CMU: Sudden loss of clock does not signal the Fault Collection and Control Unit

### Description

The Clock Monitor Unit (CMU) detects when a monitored clock frequency drops below a programmed threshold through the Frequency Less than Low Threshold (FLL) signal. This FLL signal is routed to the Fault Collection and Control Unit ( FCCU ) providing a mechanism to react to the clock fault. Due to its implementation, the FLL signal will not be triggered when the monitored clock source suddenly stops.

### Workaround

The CMU has an internal signal which is designed to give an indication that the monitored clock has dropped below 1/4 of the reference clock CLKMT0\_RMN. This provides an alternative means to detect the sudden loss of clock, however since this internal signal is not routed to the FCCU, the user software must periodically poll bitfield [3] of CMU\_ISR register to detect a sudden loss of clock. Write '0b1' to clear the bitfield [3] of CMU\_ISR after enabling CMU.

## ERR011293: EMIOS: For any UC operating in OPWFMB mode the Channel Count register should not be written with a value greater than Channel B Data register value

### Description

For any Unified Channel (UC) running in Output Pulse-Width and Frequency Modulation Buffered (OPWFMB) mode, Channel Control Register MODE bitfield = 7'h1011000 or 7'h1011010, the internal counter runs from 0x1 to Channel B Data register value.

The internal counter can be overwritten by software using the Channel Count register during 'freeze' operation.

If a counter wrap occurs due to overwriting of the counter with a value greater than its expiry value (B Data Register value); then the output signal behavior cannot be guaranteed.

### Workaround

For any UC operating in OPWFMB mode the Channel Count register should not be written with a value greater than Channel B Data register value.

## ERR011294: EMIOS: OPWFMB and MCB mode counter rollover resets the counter to 0x0 instead of 0x1 as mentioned in the specification

### Description

When the enhanced Modular Input/Output System (eMIOS) is used in Output Pulse-Width and Frequency Modulation Buffered (OPWFMB) or Modulus Counter Buffered (MCB) modes, when the counter rolls over, the counter returns to 0x0 instead of 0x1 as specified in the reference manual.

### Workaround

In order to avoid the counter wrap condition:

1. Make sure internal counter value is within the 0x1 to (B1 register) value range when the OPWFMB mode is entered.

2. Overwrite of Channel Count register by forcing 'freeze' in OPWFMB mode should not be outside the range of 0x1 to (B register) value.

### **ERR011295: EMIOS: In OPWFMB mode, A1/B1 registers do not get reloaded with A2/B2 register values if counter value returns 0x1 after counter wrap condition**

#### **Description**

In Output Pulse-Width and Frequency Modulation Buffered (OPWFMB) mode, A1/B1 registers do not get reloaded with A2/B2 register values if counter value returns 0x1 after counter wrap condition.

In order to avoid the counter wrap condition make sure internal counter value is within the 0x1 to B1 register value range when the OPWFMB mode is entered. Also overwriting of Channel Count register by forcing 'freeze' in OPWFMB mode should not take internal counter outside 0x1 to B register value.

#### **Workaround**

In order to avoid the counter wrap condition:

1. Make sure internal counter value is within the 0x1 to (B1 register) value range when the OPWFMB mode is entered.
2. Overwrite of Channel Count register by forcing 'freeze' in OPWFMB mode should not be outside the range of 0x1 to (B register) value.

### **ERR011306: SAR ADC: Incorrect value of ADC power down exit delay evaluated by the formula given in PDEDR [PDED] field description**

#### **Description**

The formula in the register field ADC\_PDEDR [PDED] provides the delay between the power down bit reset and start of conversion value in number of clock cycles of the ADC module clock, however the given formula of  $PDED \times 1/[ADC\_clock\_frequency]$  is incorrect. This gives a calculated value that is too short by 1 cycle of ADC Bus clock and 1 cycle of ADC clock (AD\_clk).

#### **Workaround**

The correct formula that should be used to calculate the value for the ADC\_PDEDR[PDED] register is -  
 $(1/ADC\ Bus\ clock) + ((PDED+1) \times 1/[ADC\_clock\_frequency])$

Where:

ADC\_clock\_frequency = Frequency of ADC clock (AD\_clk)

ADC Bus clock= Module interface clock for register access (ADC\_CLK)

### **ERR011321: PIT\_RTI: Generates false RTI interrupt on re-enabling**

#### **Description**

A false Real-Time Interrupt (RTI) may be observed when the RTI module is re-enabled if, after servicing an RTI interrupt (by clearing TFLGn[TIF]), the clocks to the RTI module are disabled.

This occurs only if the RTI module clock is disabled within four RTI clock cycles of an RTI Interrupt being cleared.

## Workaround

Option 1: The user should check the RTI interrupt flag, TFLGn[TIF] before servicing the interrupt, this flag won't be set for the false/spurious interrupts.

Option 2: Ensure that the module clock to the RTI module is not disabled within four RTI clock cycles after servicing an RTI interrupt. Consult the chip-specific documentation to determine the clock period of the RTI module and implement a time delay of at least five times this period before disabling the RTI module clock.

## ERR050090: DSPI/SPI: Incorrect data may be transmitted in slave mode

### Description

If the Serial Peripheral Interface (SPI or the Deserial/Serial Peripheral Interface) is operating in slave mode, incorrect or stale data may be transmitted in next transaction without underflow interrupt generation if the set up time of the Peripheral Chip Select (PCS) to the SPI Serial Clock (SCLK) is short and the transmit FIFO may become empty after one transaction.

This can occur if the PCS to SCK is less than:

$$4 \times \text{IPG\_CLOCK\_PERIOD} + 4 \times \text{DSPI\_CLOCK\_PERIOD} + 0.5 \times \text{SCK\_CLOCK\_PERIOD}$$

Where:

IPG\_CLOCK is the internal bus clock ("system" clock)

DSPI\_CLOCK is the protocol clock.

SCK\_CLOCK is the Line-Side Serial Communication Clock.

### Workaround

When operating in slave mode, software must ensure that the time interval between PCS assertion to start of SCK Clock is greater than  $4 \times \text{IPG\_CLOCK\_PERIOD} + 4 \times \text{DSPI\_CLOCK\_PERIOD} + 0.5 \times \text{SCK\_CLOCK\_PERIOD}$ .

To meet this requirement, the Master SPI can either lengthen the PCS to SCK assertion time or decrease the frequency of the communication interface, or both.

## ERR050119: FlexRay: Disabling of FlexRay Message Buffer during the STARTUP Protocol State takes longer than expected three Slots

### Description

Disabling of FlexRay Message Buffer takes longer than the expected three Slots. This is observed, when software application tries to disable the Message Buffer during the FlexRay STARTUP protocol state (vPOC!State = POC:startup) when vPOC!StartupState = "initialize schedule" or "integration consistency check".

In this scenario, FlexRay Communication Controller keeps the specific Message buffer search results until the availability of next cycle start/segment start/slot start events and therefore prevent the disabling of Message Buffer.

Note:

1. All Message Buffers can be disabled immediately if FlexRay protocol state (vPOC!State) is in following States: "POC:default config", "POC:config", "POC:wakeup", "POC:ready", "POC:halt", "POC:startup" and (vPOC!StartupState = "POC:integration listen" or "POC: ColdStart-Listen").

2.All Message Buffers can be disabled within three slots, if FlexRay protocol state (vPOC!State) is in following states: "POC: Normal-Active" or "POC: Normal-Passive".

### Workaround

Do not disable Message Buffer, while FlexRay is in STARTUP protocol State

## ERR050130: PIT: Temporary incorrect value reported in LMTR64H register in lifier mode

### Description

When the Programmable interrupt timer (PIT) module is used in lifier mode, timer 0 and timer 1 are chained and the timer load start value (LDVAL0[TSV] and LDVAL1[TSV]) are set according to the application need for both timers. When timer 0 current time value (CVAL0[TVL]) reaches 0x0 and subsequently reloads to LDVAL0[TSV], then timer 1 CVAL1[TVL] should decrement by 0x1.

However this decrement does not occur until one cycle later, therefore a read of the PIT upper lifetime timer register (LTMR64H) is followed by a read of the PIT lower lifetime timer register (LTMR64L) at the instant when timer 0 has reloaded to LDVAL0[TSV] and timer 1 is yet to be decremented in next cycle then an incorrect timer value in LTMR64H[LTH] is expected.

### Workaround

In lifier mode if the read value of LTMR64L[LTL] is equal to LDVAL0[TSV] then read both LTMR64H and LTMR64L registers one additional time to obtain the correct lifetime value.

## ERR050144: SAI: Setting FCONT=1 when TMR>0 may not function correctly

### Description

When FCONT=1 the transmitter will recover after a FIFO error when the FIFO is no longer empty and starting again from the same word in the following frame where the error occurred.

Configuring TMR > 0 will configure one or more words in the frame to be masked (nothing transmitted during that slot). If anything other than the last word(s) in the frame are masked when FCONT=1 and a FIFO Error Flag is set, then the transmitter will not recover and will set FIFO Error Flag during each frame.

### Workaround

To avoid this issue, set FCONT in TCR4 to be 0.

## ERR050154: Clocking: Device operation is impacted with a particular MC\_CGM system divider configuration.

### Description

BAF issues SWT0 timeout destructive reset if the below conditions are met:

- 1) MC\_CGM divider configuration was programmed in application such that ratio of MC\_CGM\_SC\_DC0[DIV] and MC\_CGM\_SC\_DC5[DIV] is 1 and
- 2) Short functional reset is issued.

## Workaround

Do not configure any functional reset source in MC\_RGM\_FESS to generate short functional reset in this clocking configuration.

### **ERR050195: MEMU\_0: MEMU\_0 operation is impacted with a particular MC\_CGM system divider configuration.**

#### Description

Register read-write access on MEMU\_0 may not happen correctly if the ratio of MC\_CGM\_SC\_DC0[DIV] and MC\_CGM\_SC\_DC5[DIV] is 1.

#### Workaround

Do not perform register read write access on MEMU\_0 or disable MEMU\_0 when this clocking configuration is used.

### **ERR050196: STANDBY EXIT: Device may not come out of reset if a short functional reset comes immediately after wakeup event.**

#### Description

The device may get stuck in STANDBY exit sequence if a short functional reset is observed between wakeup event and low power mode exit.

A destructive or POR reset after short functional reset will recover the device out of the stuck condition.

#### Workaround

Do not configure any functional reset source in MC\_RGM\_FESS to generate short functional reset before entering low power mode.

### **ERR050246: FlexCAN: Receive Message Buffers may have its Code Field corrupted if the Receive FIFO function is used**

#### Description

If the Code Field of a Receive Message Buffer is corrupted it may deactivate the Message Buffer, so it is unable to receive new messages. It may also turn a Receive Message Buffer into any type of Message Buffer as defined in the Message buffer structure section in the device documentation.

The Code Field of the FlexCAN Receive Message Buffers (MB) may get corrupted if the following sequence occurs.

- 1- A message is received and transferred to an MB (i.e. MBx)
- 2- MBx is locked by software for more than 20 CAN bit times (time determines the probability of erratum to manifest).
- 3- SMB0 (Serial Message Buffer 0) receives a message (i.e. message1) intended for MBx, but destination is locked by the software (as depicted in point 2 above) and therefore NOT transferred to MBx.
- 4- A subsequent incoming message (i.e. message2) is being loaded into SMB1 (as SMB0 is full) and is evaluated by the FlexCAN hardware as being for the FIFO.

5- During the message2, the MBx is unlocked. Then, the content of SMB0 is transferred to MBx and the CODE field is updated with an incorrect value.

The problem does not occur in cases when only Rx FIFO or only a dedicated MB is used (i.e. either RX MB or Rx FIFO is used). The problem also does not occur when the Enhanced Rx FIFO and dedicated MB are used in the same application. The problem only occurs if the FlexCAN is programmed to receive in the Legacy FIFO and dedicated MB at the same application.

### Workaround

This defect only applies if the Receive FIFO (Legacy Rx FIFO) is used. This feature is enabled by RFEN bit in the Module Control Register (MCR). If the Rx FIFO is not used, the Receive Message Buffer Code Field is not corrupted.

If available on the device, use the enhanced Rx FIFO feature instead of the Legacy Rx FIFO. The Enhanced Rx FIFO is enabled by the ERFEN bit in the Enhanced Rx FIFO Control Register (ERFCR).

The defect does not occur if the Receive Message Buffer lock time is less than or equal to the time equivalent to 20 x CAN bit time.

The recommended way for the CPU to service (read) the frame received in a mailbox is by the following procedure:

1. Read the Control and Status word of that mailbox.
2. Check if the BUSY bit is deasserted, indicating that the mailbox is not locked. Repeat step 1) while it is asserted.
3. Read the contents of the mailbox.
4. Clear the proper flag in the IFLAG register.
5. Read the Free Running Timer register (TIMER) to unlock the mailbox

In order to guarantee that this procedure occurs in less than 20 CAN bit times, the MB receive handling process in software (step 1 to step 5 above) should be performed as a 'critical code section' (interrupts disabled before execution) and should ensure that the MB receive handling occurs in a deterministic number of cycles.

## ERR050467: PLL: Possible loss of lock when using the PLL bypass calibration mode

### Description

A momentary PLL loss of lock may occur shortly after enabling the PLL if using the PLL bypass calibration mode (PLLDIG\_PLLCAL1[BYPCAL] = 1). Note that the PLLDIG\_PLLCAL1[BYPCAL] bit is set by default after exiting the low power STANDBY mode.

### Workaround

Do not use the PLL bypass calibration mode and instead ensure PLLDIG\_PLLCAL1[BYPCAL] is cleared before enabling the PLL.

## ERR050572: SIRC: Clock output may contain extra clock pulses

### Description

The 128 kHz Slow Internal RC (SIRC) oscillator may generate an extra clock pulse per clock period. The occurrence of the potential extra clock pulse may vary for each clock period ranging from no extra clock pulse to

one extra clock pulse per period. Factors that affect the occurrence rate are part to part variations, temperature, and core voltage.

The SIRC output clock may be selected as the clock source for the Real Time Clock (RTC) via the RTC\_RTCC[CLKSEL] register, as a clock to monitor in the Clock Monitor Unit (CMU) via the CMU\_CSR[CLKSEL1] register, or as the clock source for the Software Watchdog Timer (SWT) timers (SWTx, HSM\_SWT). The RTC, CMU, and SWT counters/timers may get an extra clock per SIRC clock period causing a higher than expected count (which may affect the RTC count/wakeup duration, the CMU measured SIRC frequency, or the SWT time-out period) or may cause a corrupted count value. The SIRC clock may also be selected to the CLKOUT\_0 and CLKOUT\_1 pins in which the extra pulse may or may not be observable for a divide by 1 configuration and for non-divide by 1 configurations may affect the divided clock duty cycle or may corrupt or stall the divided clock waveform.

### Workaround

Select other clock sources for the RTC. The RTC supports other clock sources via the RTC\_RTCC[CLKSEL] register which include selections for the 32 kHz Slow External Crystal Oscillator (SXOSC), the 16 MHz Fast Internal RC Oscillator (FIRC), or the 8-40 MHz Fast External Crystal Oscillator (FXOSC). If the RTC uses the SIRC clock, then the application needs to manage possible unexpected counter values such as count values that are double the expected value.

If the CMU monitors the SIRC clock, then the application needs to manage possible unexpected measured SIRC frequencies based on possible unexpected counter values such as frequencies that are double the expected value.

The application needs to account for the possibility of a quicker SWT timeout for any SWT that is enabled. Other timer sources such as a PIT timer may be used to compliment the SWT counts.

If the CLKOUTx pin selects the SIRC clock source, then the application needs to manage the possible unexpected CLKOUT waveforms.

## **ERR050575: eMIOS: Any Unified Channel running in OPWMCB mode may function improperly if the lead or trail dead time insertion features is used and its timebase is generated by Unified channel in MCB mode**

### Description

The Unified channel (UC) configured in Center Aligned Output Pulse Width Modulation Buffered (OPWMCB) mode is not working properly when:

1. Its timebase is sourced from the UC configured in Modulus Counter Buffered (MCB) mode.
2. The lead or trail dead time insertion features is used.
3. Its channel prescaler is different than timebase channel prescaler.

### Workaround

Channel configured in OPWMCB mode with lead or trail dead time insertion features enabled must have channel prescaler equal to the timebase channel prescaler configured in MCB mode.

**ERR052226: SWT: Toggling watchdog enable may cause unexpected timeout in some boundary conditions****Description**

The Software Watchdog Timer (SWT) may timeout unexpectedly when loading a new timeout value. This can occur when the SWT is paused (CR[WEN]=0b0) to update the TO[WTO], while the counter is less than 0x14 (CO[CNT] = 0x14). When SWT is re-enabled (CR[WEN]=0b1), the SWT resumes the cycle count, but the counter is not updated (CO[CNT]) with the new timeout value before the cycle counter reaches zero.

**Workaround**

Before setting a new timeout value (TO[WTO]) the SWT must be updated with the watchdog keys ( (SR[WSC]= 0xA602) and then (SR[WSC] = 0xB480) ) to restart the counter value and have the timeout change being made within the appropriate time window, preventing the counter from reaching zero.

**ERR052559: INTC: Register updated on bus error****Description**

The Interrupt Controller (INTC) defines register field PSR.SWTN as protected. Only the master core should be allowed to write. Other writes should generate a bus error. Such writes should be dropped, but due to this issue, they are not.

**Workaround**

Only write PSR.SWTN from master core

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